Se	arch No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/899,984	HEUER, VOLKMAR	
Examiner	Art Unit	
John L. Shew	2664	

	SEAR	CHED	-
Class	Subclass	Date	Examiner
370	217,218	.5/27/2005	JS
	222,223		
	225,237		
	353-355		
	390		
	395.21		
	404-406		
	452	-	
398	2-4	5/27/2005	JS
	45		

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner

	DATE	EXMR
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